

Notice of References Cited	Application/Control No. 10/718,424	Applicant(s)/Patent Under Reexamination BAILEY ET AL.	
	Examiner Leigh McKane	Art Unit 1744	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,269,717	05-1981	Slovinsky, Manuel	210/750
	B	US-4,775,005	10-1988	Beyer et al.	165/134.1
	C	US-5,236,845	08-1993	Pierce et al.	436/6
	D	US-6,391,256	05-2002	Moon et al.	422/14
	E	US-6,402,984	06-2002	Nakajima et al.	252/188.1
	F	US-2003/0004681	01-2003	Fandrich et al.	702/183
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO0159535A1	08-2001	WIPO	FANDRICH et al	-----
	O	JP2003254503A	09-2003	JP	MORIMOTO et al	-----
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.